

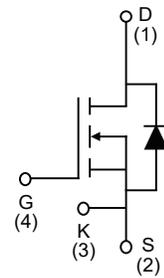
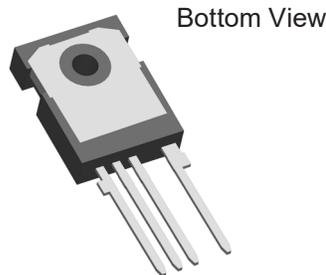
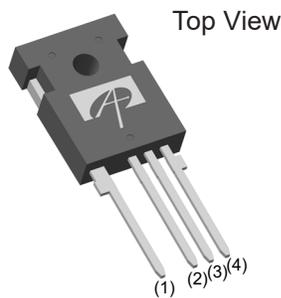
Features

- Proprietary α SiC MOSFET technology
- Low loss, fast switching speeds with low R_G
- Optimized drive voltage ($V_{GS} = 15V$) for broad driver compatibility
- Robust body diode and low Q_{rr}
- AEC-Q101 Automotive Qualified

Applications

- xEV Charger
- Electric Vehicle Supply Equipment (EVSE)
- Motor Drives
- Automotive Inverters

Pin Configuration



Product Summary

$V_{DS} @ T_{J, max}$	1200V
I_{DM}	200A
$R_{DS(ON), typ}$	20m Ω
Q_{rr}	225nC
$E_{OSS} @ 800V$	88 μ J
100% UIS Tested	



Ordering Part Number	Package Type	Form	Shipping Quantity
AOM020V120X2Q	TO-247-4L	Tube	30/Tube

Absolute Maximum Ratings

($T_A = 25^\circ C$, unless otherwise noted)

Symbol	Parameter	AOM020V120X2Q	Units
V_{DS}	Drain-Source Voltage	1200	V
$V_{GS, MAX}$	Gate-Source Voltage	Maximum	-8/+18
$V_{GS, OP, TRANS}$		Max Transient ^(A)	-8/+20
$V_{GS, OP}$		Recommended Operating ^(B)	-5/+15
I_D	Continuous Drain Current	$T_C = 25^\circ C$	89
		$T_C = 100^\circ C$	63
I_{DM}	Pulsed Drain Current ^(C)	200	A
E_{AS}	Single Pulsed Avalanche Energy ^(D)	1.0	J
P_D	Power Dissipation ^(C)	$T_C = 25^\circ C$	348
T_J, T_{STG}	Junction and Storage Temperature Range	-55 to 175	$^\circ C$
T_L	Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds	300	$^\circ C$

Thermal Characteristics

Symbol	Parameter	AOM020V120X2Q		Units
		Typ	Max	
$R_{\theta JA}$	Maximum Junction-to-Ambient ^(E,F)		40	°C/W
$R_{\theta JC}$	Maximum Junction-to-Case ^(G)	0.34	0.43	°C/W

Electrical Characteristics

($T_A = 25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units	
STATIC							
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}, T_J = 25^\circ\text{C}$	1200			V	
		$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}, T_J = 175^\circ\text{C}$	1200			V	
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 1200\text{V}, V_{GS} = 0\text{V}$			100	μA	
I_{GSS}	Gate-Body Leakage Current	$V_{DS} = 0\text{V}, V_{GS} = +15/-5\text{V}$			± 200	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 27\text{mA}$		2.8		V	
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = 15\text{V}, I_D = 27\text{A}$	$T_J = 25^\circ\text{C}$	20	28	m Ω	
			$T_J = 175^\circ\text{C}$	32		m Ω	
g_{FS}	Forward Transconductance	$V_{DS} = 20\text{V}, I_D = 27\text{A}$		23		S	
V_{SD}	Diode Forward Voltage	$I_S = 27\text{A}, V_{GS} = -5\text{V}$		4.3	5	V	
DYNAMIC							
C_{iss}	Input Capacitance	$V_{GS} = 0\text{V}, V_{DS} = 800\text{V}, f = 1\text{MHz}$		5180		pF	
C_{oss}	Output Capacitance			208		pF	
C_{riss}	Reverse Transfer Capacitance			18		pF	
E_{oss}	Coss Stored Energy			88		μJ	
R_G	Gate Resistance	$f = 1\text{MHz}$		1		Ω	
SWITCHING							
Q_g	Total Gate Charge	$V_{GS} = -5/+15\text{V}, V_{DS} = 800\text{V}, I_D = 30\text{A}$		166		nC	
Q_{gs}	Gate Source Charge			55		nC	
Q_{gd}	Gate Drain Charge			39		nC	
$t_{D(on)}$	Turn-On Delay Time	$V_{GS} = -5\text{V}/+15\text{V}, V_{DS} = 800\text{V}, I_D = 30\text{A}, R_G = 2\Omega$		15		ns	
t_r	Turn-On Rise Time			13		ns	
$t_{D(off)}$	Turn-Off Delay Time			21		ns	
t_f	Turn-Off Fall Time			13		ns	
E_{on}	Turn-On Energy		$L_a = 60\mu\text{H}$		278		μJ
E_{off}	Turn-Off Energy	FWD: AOM020V120X2Q		81		μJ	
E_{tot}	Total Switching Energy			359		μJ	
t_{rr}	Body Diode Reverse Recovery Time	$I_F = 30\text{A}, di/dt = 1500\text{A}/\mu\text{s}, V_{GS} = -5\text{V}, V_{DS} = 800\text{V}$		17		ns	
I_{rm}	Peak Reverse Recovery Current				24		A
Q_{rr}	Body Diode Reverse Recovery Charge				225		nC

Notes:

- $t_{ON} < 1\% \cdot (\text{Duty Cycle}) / (\text{Frequency})$, $t < 25$ hrs over lifetime
- Device can be operated at $V_{GS} = 0/15\text{V}$. Actual operating VGS will depend on application specifics such as parasitic inductance and dV/dt but should not exceed maximum ratings.
- The power dissipation P_D is based on $T_{J(MAX)} = 175^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- $L = 5\text{mH}, I_{AS} = 22\text{A}, R_G = 10\Omega$, Starting $T_J = 25^\circ\text{C}$.
- The value of $R_{\theta JA}$ is measured with the device in a still air environment

- with $T_A = 25^\circ\text{C}$.
- The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.
- The value of $R_{\theta JC}$ is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)} = 175^\circ\text{C}$.
- The static characteristics in Figures 1 to 8 are obtained using $< 300\mu\text{s}$ pulses, duty cycle 0.5% max.
- These curves are based on $R_{\theta JC}$ which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)} = 175^\circ\text{C}$. The SOA curve provides a single pulse rating.

Typical Electrical and Thermal Characteristics (Continued)

T_A = 25°C, unless otherwise specified.

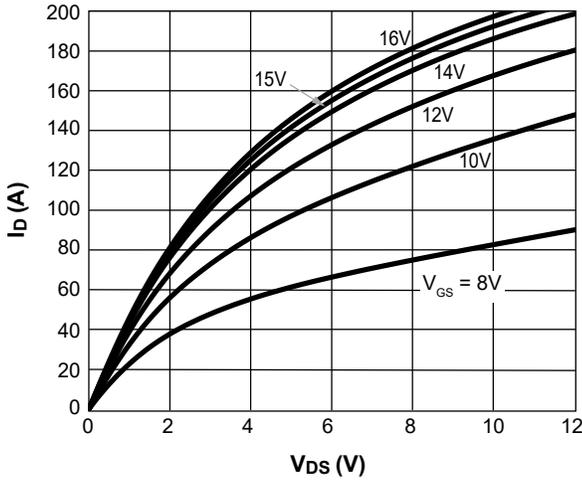


Figure 1. On-Region Characteristics T_J = 25°C

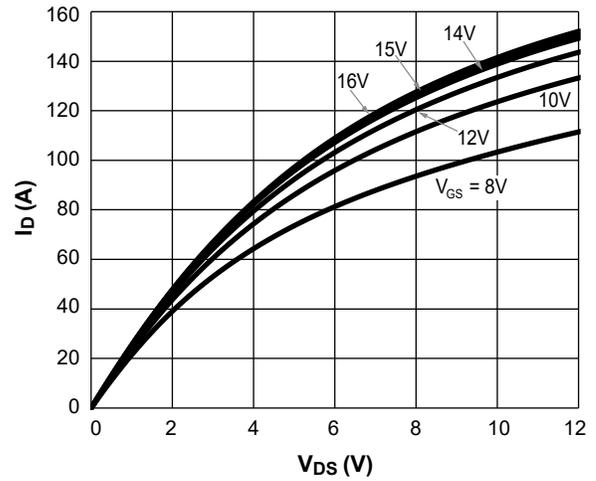


Figure 2. On-Region Characteristics T_J = 175°C

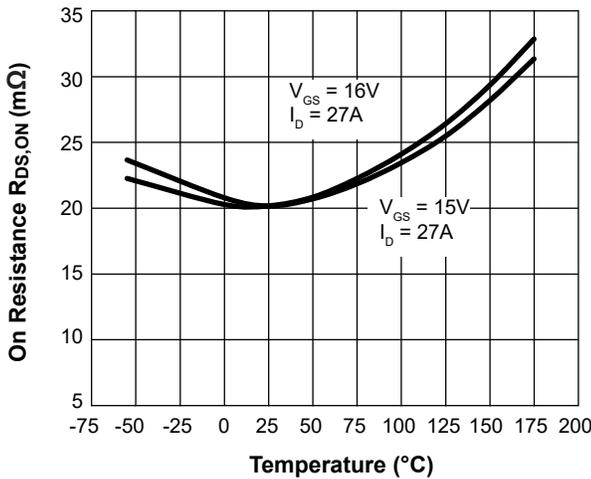


Figure 3. On Resistance vs. Junction Temperature

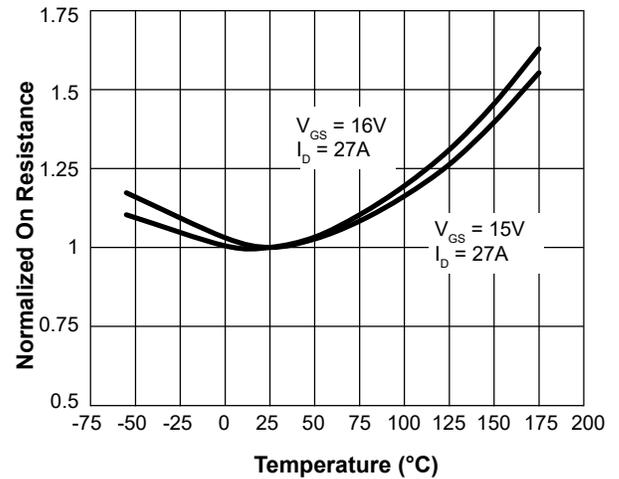


Figure 4. Normalized On Resistance vs. Junction Temperature

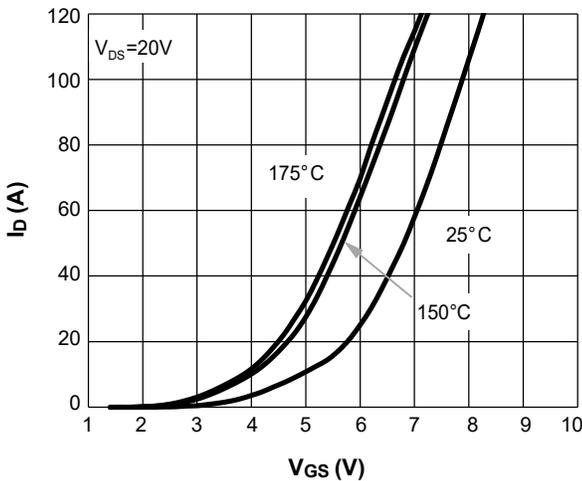


Figure 5. Transfer Characteristics

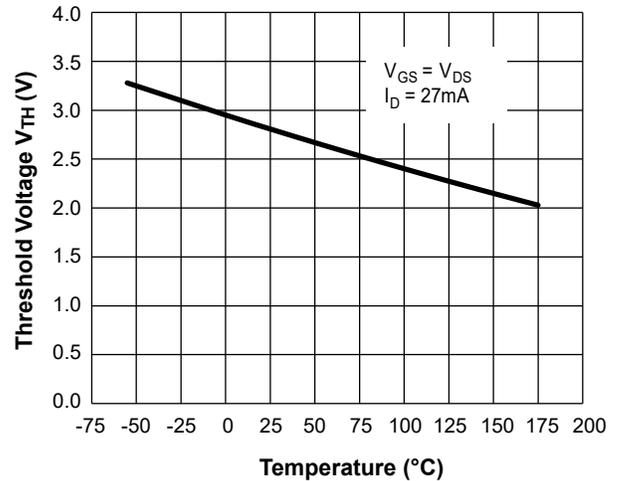


Figure 6. Threshold Voltage vs. Junction Temperature

Typical Electrical and Thermal Characteristics (Continued)

T_A = 25°C, unless otherwise specified.

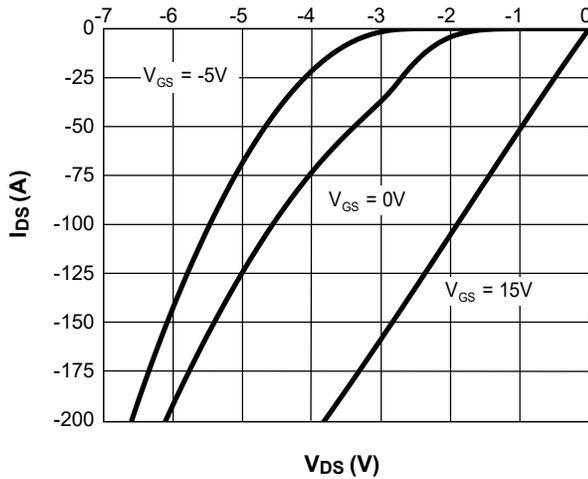


Figure 7. Body-diode Characteristics at 25°C

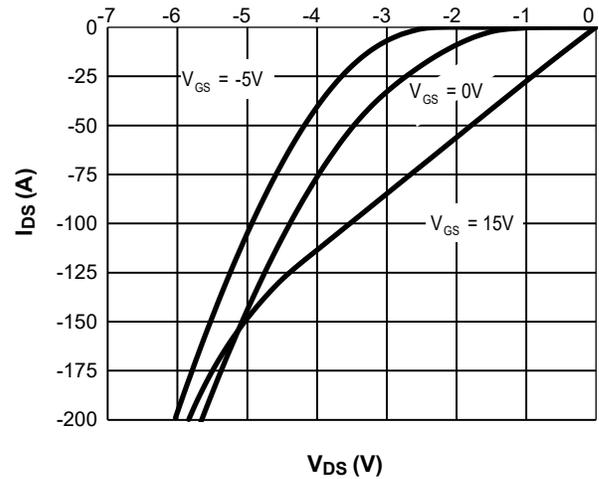


Figure 8. Body-diode Characteristics at 175°C

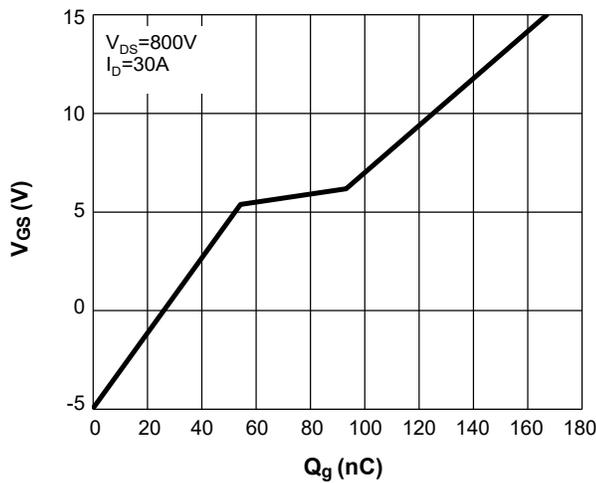


Figure 9. Gate-charge Characteristics

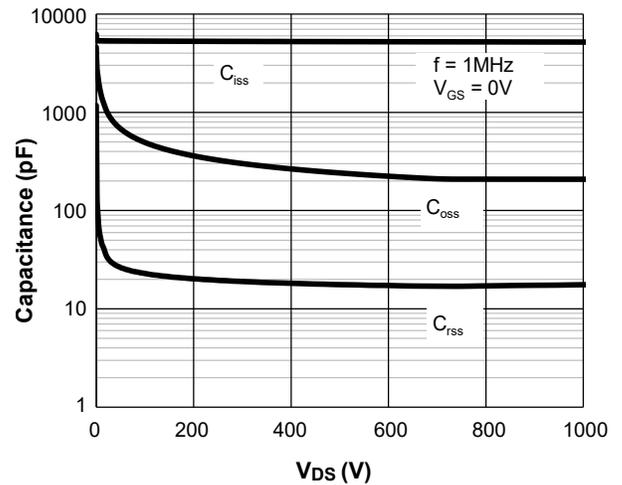


Figure 10. Capacitance Characteristics

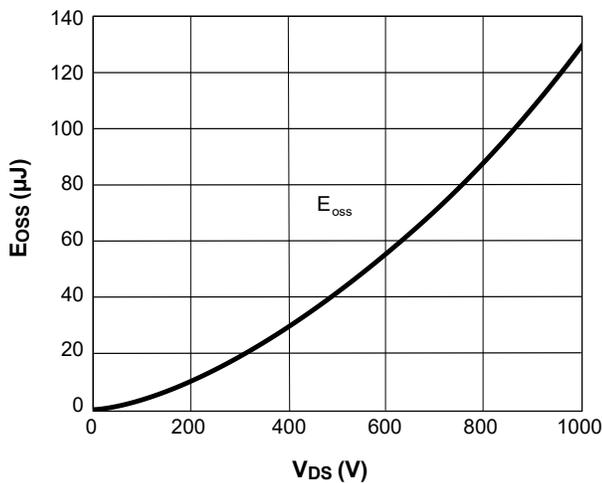


Figure 11. Coss Stored Energy

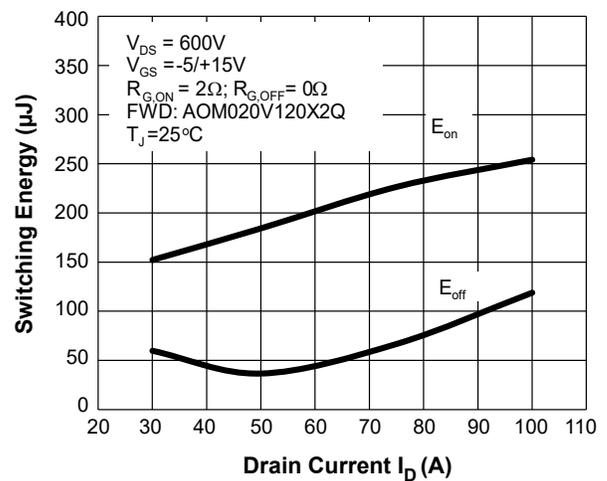


Figure 12. Switching Energy vs. Drain Current

Typical Electrical and Thermal Characteristics (Continued)

$T_A = 25^\circ\text{C}$, unless otherwise specified.

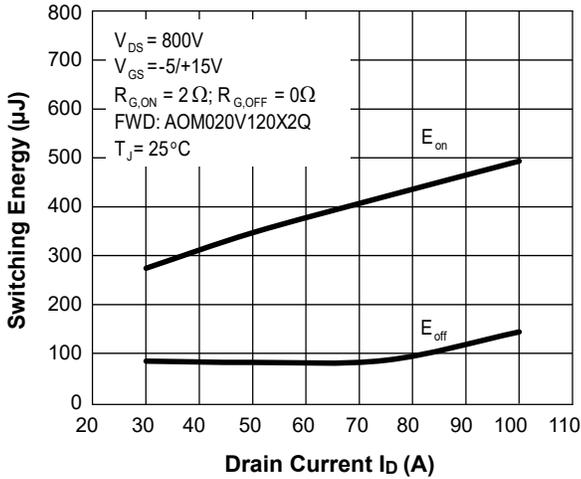


Figure 13. Switching Energy vs. Drain Current

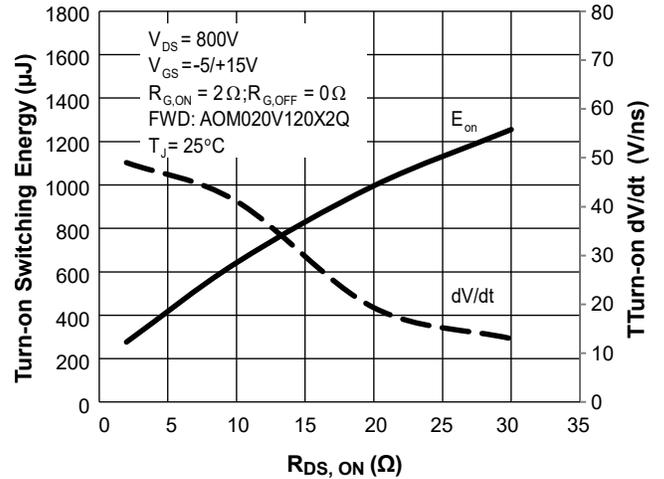


Figure 14. Turn-on Energy and dV/dt vs. External Gate Resistance

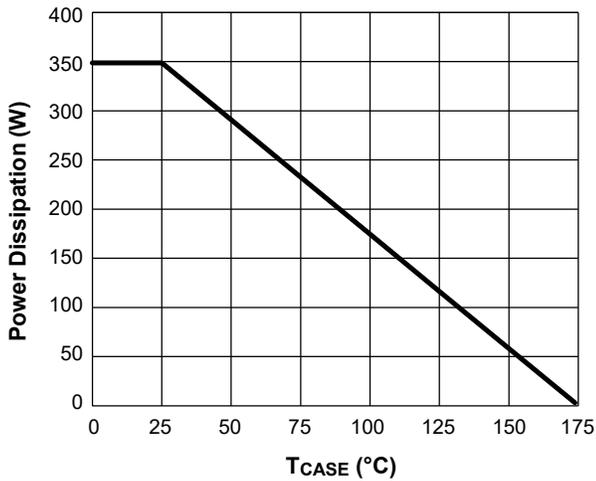


Figure 15. Power De-rating (Note 1)

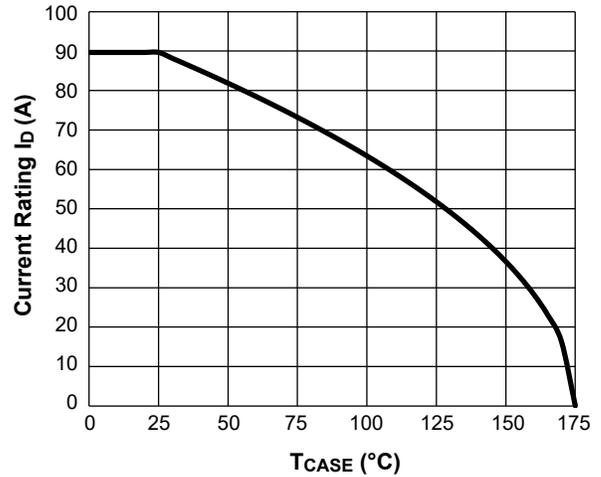


Figure 16. Current De-rating (Note 1)

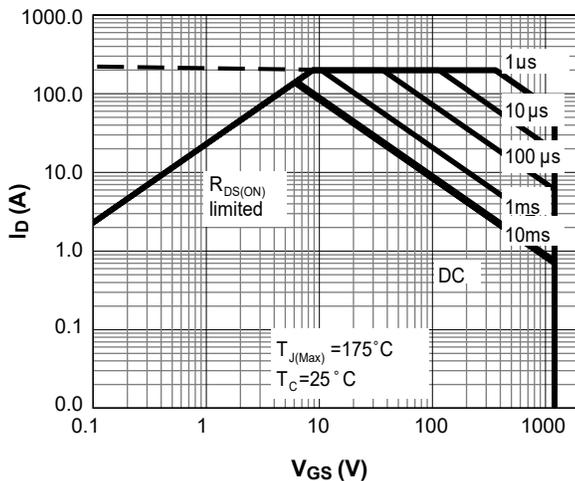


Figure 17. Maximum Forward Biased Safe Operating Area for AOM020V120X2Q (Note 1)

Typical Electrical and Thermal Characteristics (Continued)

T_A = 25°C, unless otherwise specified.

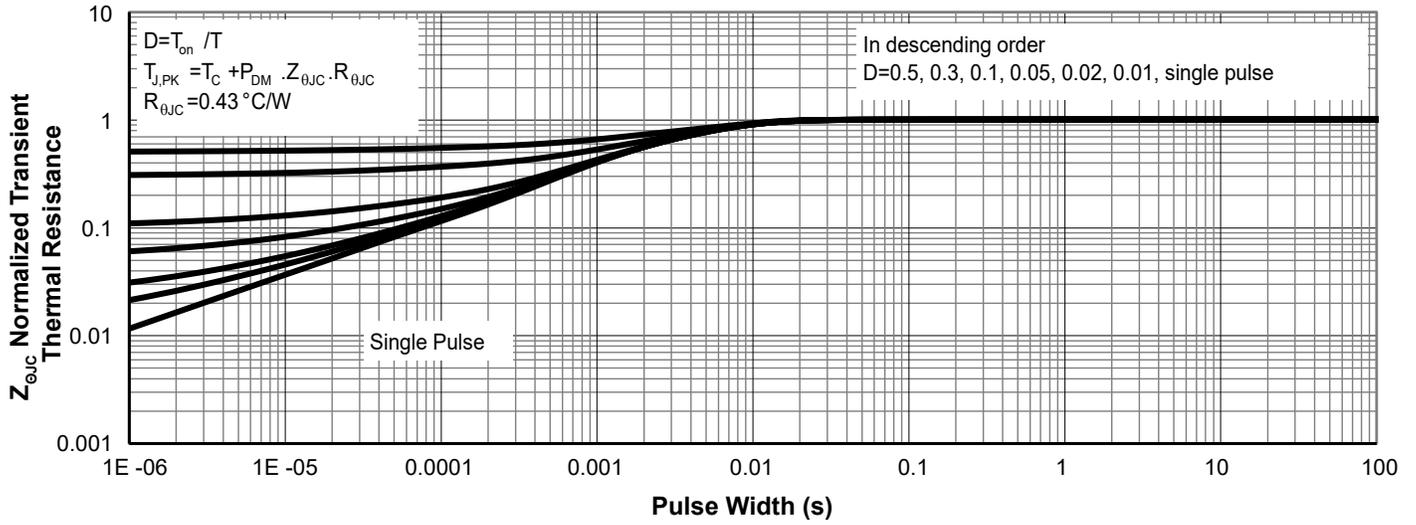


Figure 18. Normalized Maximum Transient Thermal Impedance for AOM020V120X2Q (Note I)

Test Circuits and Waveforms

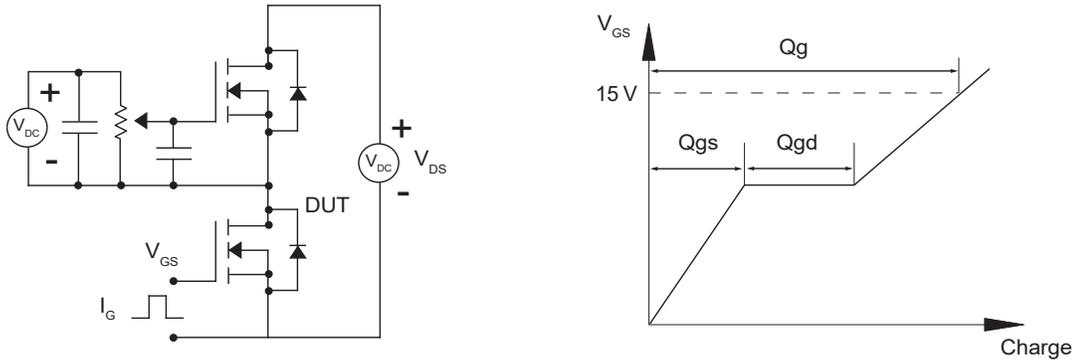


Figure 19. Gate Charge Test Circuits and Waveforms

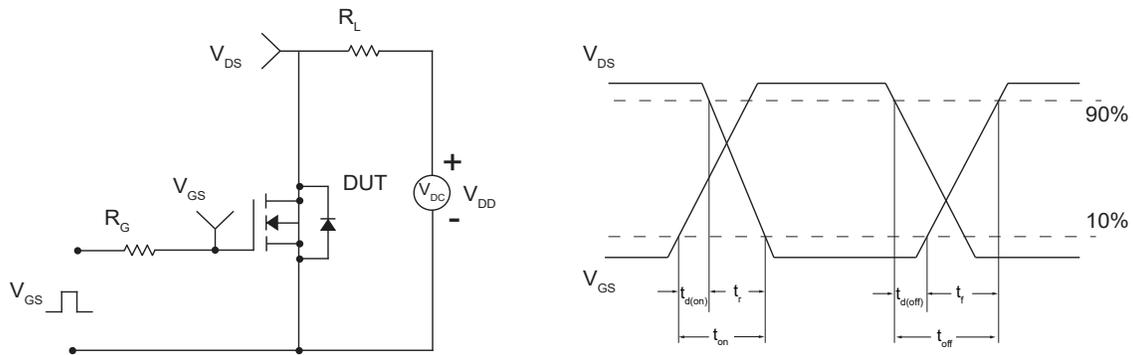


Figure 20. Resistive Switching Test Circuit and Waveforms

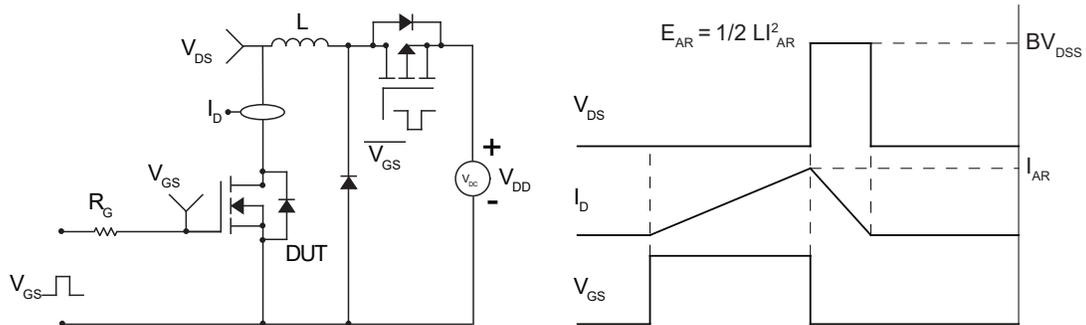


Figure 21. Unclamped Inductive Switching (UIS) Test Circuit and Waveforms

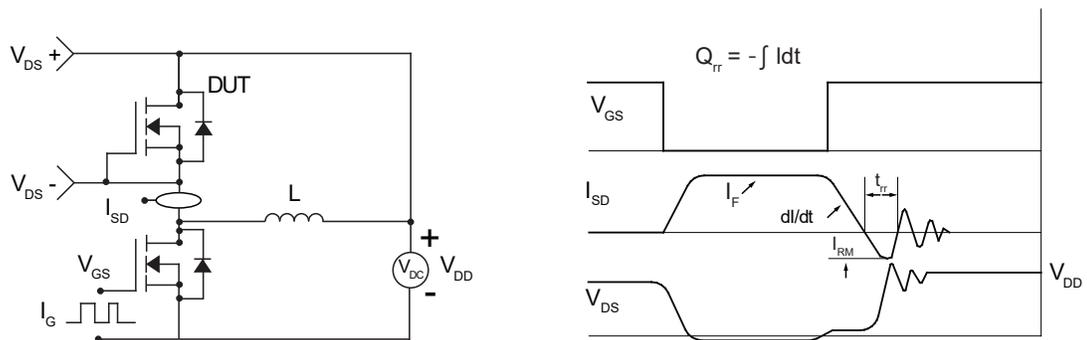
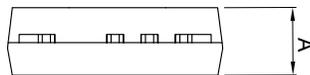
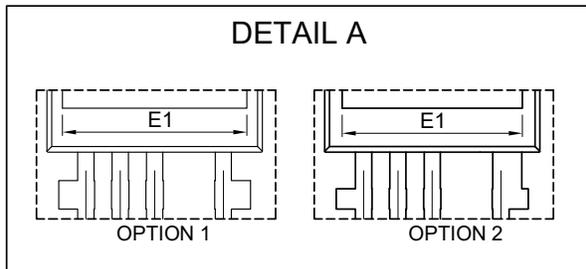
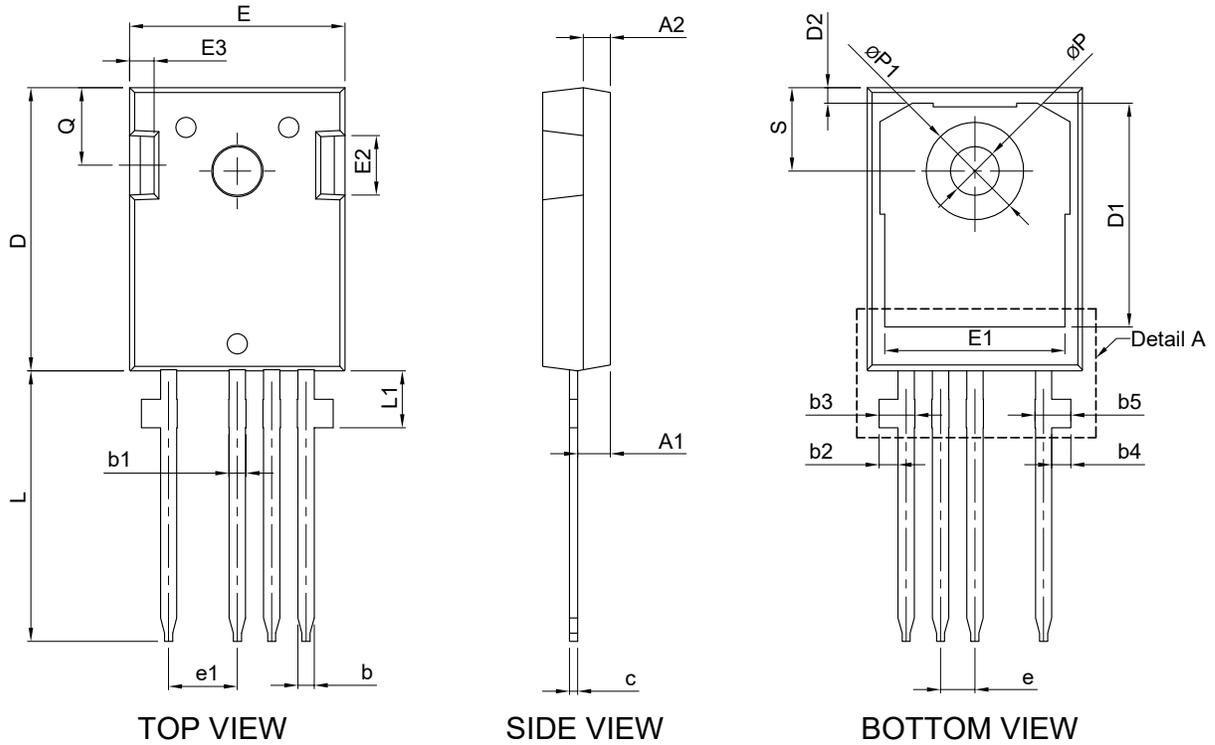
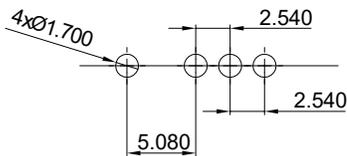


Figure 22. Diode Recovery Test Circuits and Waveforms

Package Dimensions, TO-247-4L



SIDE VIEW



RECOMMENDED THROUGH HOLES FOR LAND PATTERN

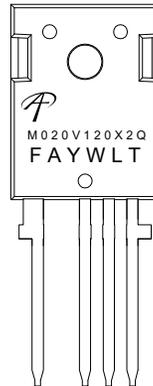
SYMBOLS	DIM. IN MM			DIM. IN INCH		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	4.90	5.00	5.10	0.193	0.197	0.201
A1	2.29	2.42	2.54	0.090	0.095	0.100
A2	1.90	2.00	2.10	0.075	0.079	0.083
b	1.17	1.22	1.27	0.046	0.048	0.050
b1	1.20	1.30	1.40	0.047	0.051	0.055
b2	1.31	1.41	1.51	0.052	0.056	0.059
b3	2.45	2.65	2.85	0.096	0.104	0.112
b4	1.31	1.41	1.51	0.052	0.056	0.059
b5	2.45	2.65	2.85	0.096	0.104	0.112
c	0.57	0.62	0.67	0.022	0.024	0.026
D	20.80	20.95	21.10	0.819	0.825	0.831
D1	16.25	16.55	16.85	0.640	0.652	0.663
D2	1.00	1.15	1.30	0.039	0.045	0.051
E	15.77	15.92	16.07	0.621	0.627	0.632
E1(Option1)	13.43	13.63	13.83	0.529	0.537	0.544
E1(Option2)	13.18	13.33	13.48	0.519	0.525	0.531
E2	4.29	4.39	4.49	0.169	0.173	0.177
E3	1.70	1.80	1.90	0.067	0.071	0.075
e	2.54BSC			0.1000BSC		
e1	5.08BSC			0.2000BSC		
N	4			4		
L	19.82	20.02	20.22	0.780	0.788	0.796
L1	4.01	4.21	4.41	0.158	0.166	0.174
P	3.50	3.60	3.70	0.138	0.142	0.146
P1	7.00	7.20	7.40	0.276	0.283	0.291
Q	5.65	5.75	5.85	0.222	0.226	0.230
S	6.07	6.17	6.27	0.239	0.243	0.247

NOTE:

- CONTROLLED DIMENSIONS ARE IN MILLIMETERS.

Part Marking

AOM020V120X2Q
TO-247-4L



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